

Notice of References Cited	Application/Control No. 10/773,990		Applicant(s)/Patent Under Reexamination BARR ET AL.	
	Examiner Sin J. Lee		Art Unit 1752	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0028404	03-2002	Nakamura, Ippei	430/270.1
	B	US-			
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	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP9-34110	02-1997	Japan	Nakayama	N/A
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	JPO English abstract for JP 9-34110 (Nakayama).
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